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# 2SD2504

### Silicon NPN epitaxial planar type

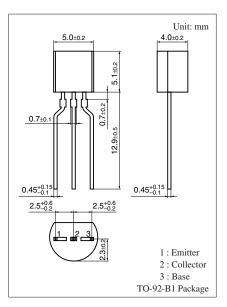
For low-frequency power amplification

#### Features

- Low collector-emitter saturation voltage  $V_{CE(sat)}$
- $\bullet$  Large collector current  $I_{C}$

#### Absolute Maximum Ratings $T_a = 25^{\circ}C$

Parameter	Symbol	Rating	Unit	
Collector-base voltage (Emitter open)	V <sub>CBO</sub>	15	V	
Collector-emitter voltage (Base open)	V <sub>CEO</sub>	10	V	
Emitter-base voltage (Collector open)	V <sub>EBO</sub>	10	V	
Collector current	I <sub>C</sub>	5	А	
Peak collector current *	I <sub>CP</sub>	9	А	
Collector power dissipation	P <sub>C</sub>	750	mW	
Junction temperature	Tj	150	°C	
Storage temperature	T <sub>stg</sub>	-55 to +150	°C	



Note) \*: t = 380 µs

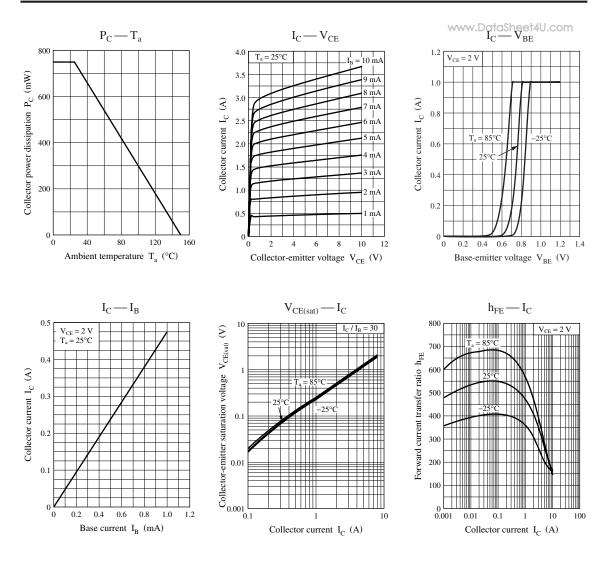
#### Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

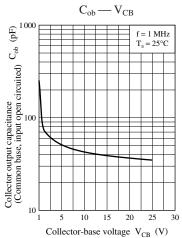
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emitter open)	V <sub>CBO</sub>	$I_{C} = 1 \text{ mA}, I_{E} = 0$	10			V
Collector-emitter voltage (Base open)	V <sub>CEO</sub>	$I_{\rm C} = 10 \ \mu A, \ I_{\rm B} = 0$	10			V
Collector-base cutoff current (Emitter open)	I <sub>CBO</sub>	$V_{CB} = 10 \text{ V}, I_E = 0$			0.1	μΑ
Collector-emitter cutoff current (Base open)	I <sub>CEO</sub>	$V_{CE} = 5 V, I_B = 0$			1.0	μΑ
Emitter-base cutoff current (Collector open)	I <sub>EBO</sub>	$V_{EB} = 5 V, I_E = 0$			0.1	μΑ
Forward current transfer ratio *	h <sub>FE1</sub>	$V_{CE} = 2 V, I_C = 0.5 A$	300		800	
	h <sub>FE2</sub>	$V_{CE} = 2 V, I_C = 2 A$	195			
Collector-emitter saturation voltage *	V <sub>CE(sat)</sub>	$I_{\rm C} = 3 \text{ A}, I_{\rm B} = 0.1 \text{ A}$		0.28	0.50	V
Transition frequency	f <sub>T</sub>	$V_{CB} = 6 \text{ V}, I_E = -50 \text{ mA}, f = 200 \text{ MHz}$		170		MHz
Collector output capacitance	C <sub>ob</sub>	$V_{CB} = 20 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		45	65	pF
(Common base, input open circuited)						

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. \*: Pulse measurement

## Panasonic





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